## Notice of Referenc s Cited

<u>````````</u>		
Application/Control No. 09/700,171	Applicant(s)/Patent Under Reexamination IGUCHI ET AL.	
Examiner	Art Unit	
Rip A. Lee	1713	Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
	А	US-5,693,699 A	12-1997	Bertelo et al.	524	400
	В	US-3,996,173	12-1976	Heichele	260	23XA
*	С	US-4,670,509	06-1987	Aoyama et al.	525	85
	D	US-4,436,861	03-1984	Ushioda et al.	524	425
	E	US-4,507,414	03-1985	McRowe et al.	524	100
	F	US-5,124,373 A	06-1992	Baumgaertel et al.	523	210
	G	US-5,362,790 A	11-1994	Gloesener	524	425
	Н	US-				-
	ı	US-		,		
	J	US-				
	Κ	US-				
	L	US-				<u> </u>
	М	US-				

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification	
	N	FR 2,551,446 A1	08-1983	France	Meunier	C08F	265/06
	0	FR 2,551,447 A1	08-1983	France	Meunier	C08F	265/06
	Р	EP 143 194 A1	06-1985	Europe	Meunier	C08L	27/06
	Q						
	R						
	s						
	Т						

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	
	V	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.